

	Type	Hits	Search Text	DBs
1	BRS	4933	((determin\$5 or detect\$5 or measur\$5 or inspect\$5 or examin\$5) near4 (defect\$5 or moisture or oil or particle or foreign or imperfect\$5)) near8 film	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB
2	BRS	112541	(\$5sensor\$2 or \$5detect\$2) near4 (reference)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB
3	BRS	115	((((determin\$5 or detect\$5 or measur\$5 or inspect\$5 or examin\$5) near4 (defect\$5 or moisture or oil or particle or foreign or imperfect\$5)) near8 film ) and ((\$5sensor\$2 or \$5detect\$2) near4 (reference)) and @ad<=19991230	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB
4	BRS	73	((((determin\$5 or detect\$5 or measur\$5 or inspect\$5 or examin\$5) near4 (defect\$5 or moisture or oil or particle or foreign or imperfect\$5)) near8 film ) and ((\$5sensor\$2 or \$5detect\$2) near4 (reference)) and @ad<=19991230) not semiconductor	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB